

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/782,064	MOTOYAMA ET AL.		
Examiner	Art Unit		
Quoc A. Tran	2176		

SEARCHED					
Class	Subclass	Date	Examiner		
399	1	12/28/2005	QY		
709	202	12/28/2005			
709	224	12/28/2005			
709	218	6/29/2006			
358	1.14	6/29/2006			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDBsee Search Histoty Printout	12/28/2005	W		
ACM Digital Library DataBase	12/28/2005			
EAST (US-PAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB ee Search Histoty Printout	06/29/2006			